

**ON Semiconductor®** 

# FDG8842CZ Complementary PowerTrench<sup>®</sup> MOSFET Q1:30V,0.75A,0.4Ω; Q2:–25V,–0.41A,1.1Ω Features

Q1: N-Channel

- Max  $r_{DS(on)}$  = 0.4 $\Omega$  at  $V_{GS}$  = 4.5V,  $I_D$  = 0.75A
- Max r<sub>DS(on)</sub> = 0.5Ω at V<sub>GS</sub> = 2.7V, I<sub>D</sub> = 0.67A

Q2: P-Channel

- Max  $r_{DS(on)}$  = 1.1 $\Omega$  at  $V_{GS}$  = -4.5V,  $I_D$  = -0.41A
- Max r<sub>DS(on)</sub> = 1.5Ω at V<sub>GS</sub> = -2.7V, I<sub>D</sub> = -0.25A
- Very low level gate drive requirements allowing direct operation in 3V circuits(V<sub>GS(th)</sub> <1.5V)</p>
- Very small package outline SC70-6
- RoHS Compliant

#### **General Description**

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These N & P-Channel logic level enhrourned mode field effect transistors are produced usin ON Sen conductor's proprietary, high cell density ownOS to include . This very high density process is explored tailor. To minimize on-state resistance. The device as been designed especially for revoltate appendons as a replacement for bipolar dig that is tors of small cignal MOSFETs. Since bial information of this dual digital FET can replace very dimensional transistors, with different bias resistor



## M SF / Maximum Ratings T, = 25°C unless otherwise noted

	Symbol	Parameter		Q1	Q2	Units		
	V <sub>DS</sub>	Drain to Source Voitage		30	-25	V		
[	V <sub>GS</sub>	Gate to Source Voltage		±12	-8	V		
	P	Drain Current -Continuous	0.75	-0.41	۸			
		-Pulsed		2.2	-1.2	A		
	P <sub>D</sub>	Power Dissipation for Single Operation	0.36		w			
			0.30		~ ~			
	T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	–55 to	°C				

## **Thermal Characteristics**

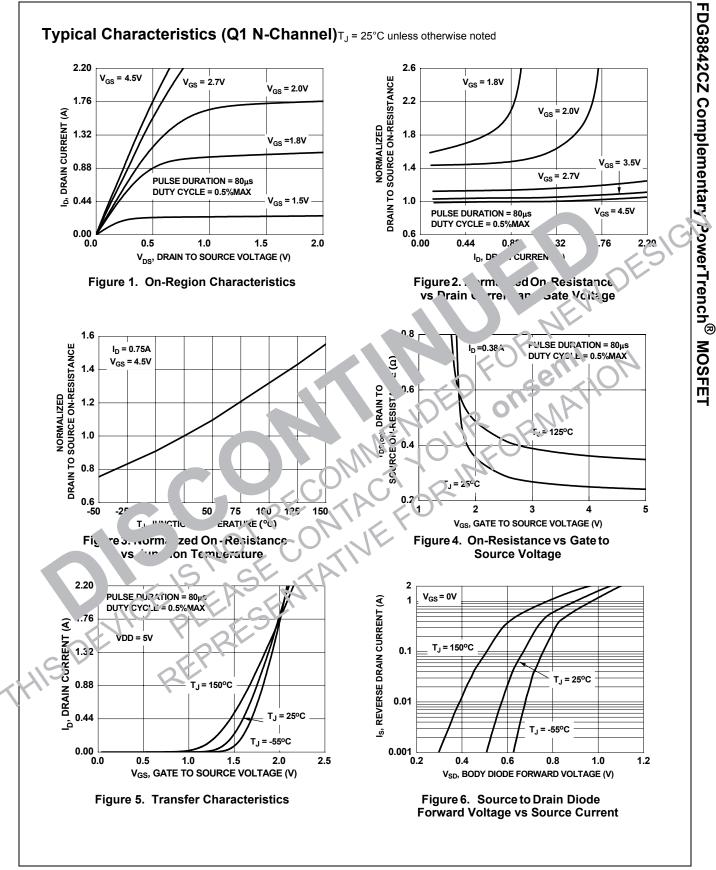
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient Single operation	(Note 1a)	350	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient Single operation	(Note 1b)	415	C/vv

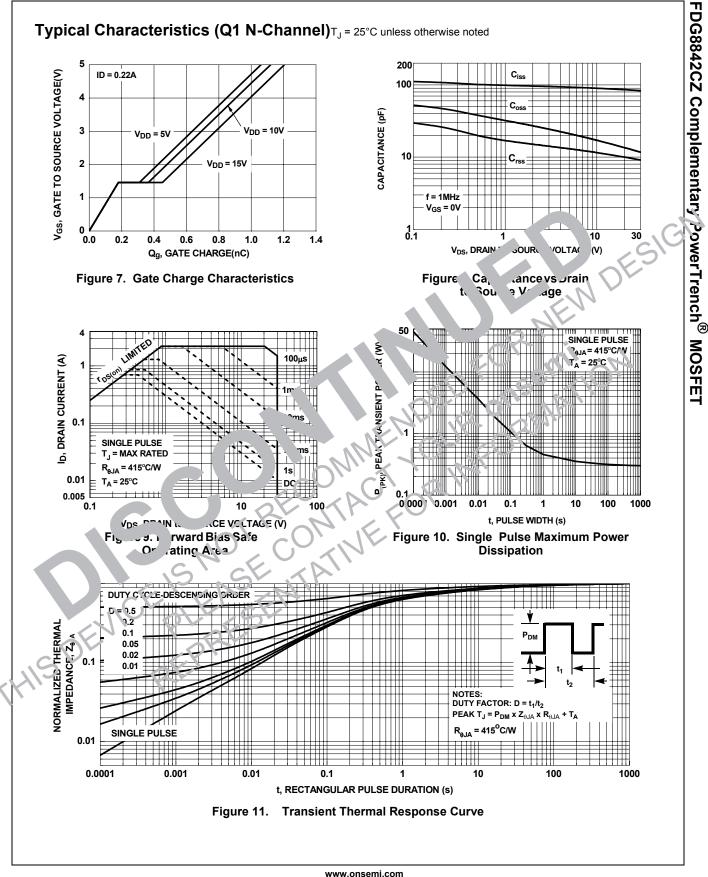
## Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity	
.42	FDG8842CZ	7"	8mm	3000 units	

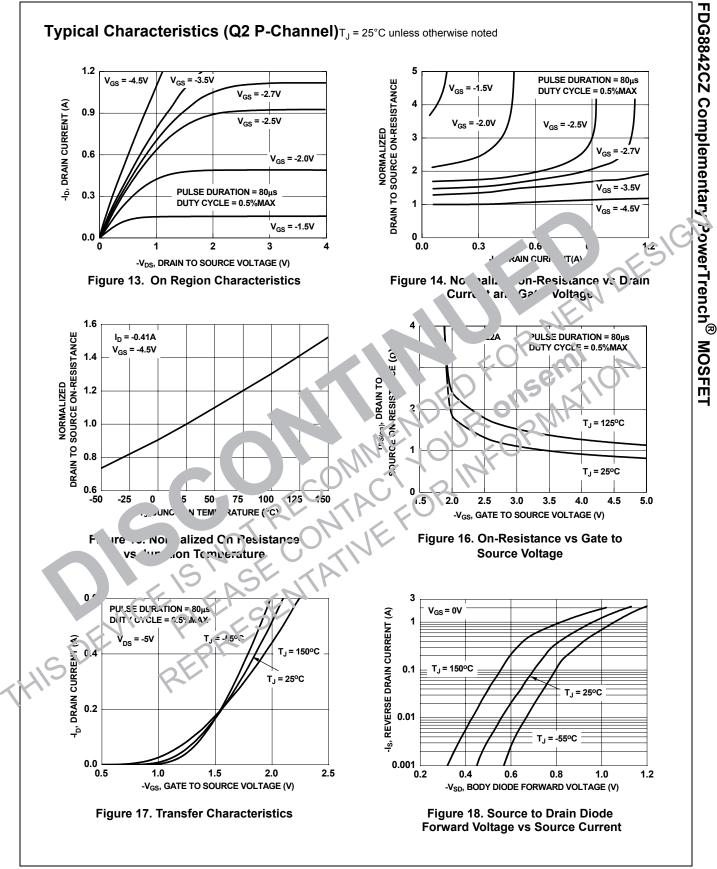
Symbol	Parameter	Test Conditions	Туре	Min	Тур	Мах	Units
Off Chara	cteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V$ $I_D = -250 \mu A, V_{GS} = 0V$	Q1 Q2	30 –25			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu$ A, referenced to 25°C $I_D = -250\mu$ A, referenced to 25°C	Q1 Q2		25 21		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24V, V_{GS} = 0V$ $V_{DS} = -20V, V_{GS} = 0V$	Q1 Q2			1 —1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 12V, V_{DS} = 0V$ $V_{GS} = -8V, V_{DS} = 0V$	Q1 Q2			±10 –100	μA nA
On Characteristics							
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = -250 \mu A$	Q1 Q2	ቦ ን5 -0.65	1.0 8	.5 1.5	S
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu$ A, referenced to 25°C $I_D = -250\mu$ A, referenced to 25°C	Qʻi 72		-ʻj 1.8		n₁√/°C
	Static Drain to Source On	$V_{GS} = 4.5V, I_D = 0.75A$ $V_{GS} = 2.7V, I_D = 0.67A$ $V_{GS} = 4.5V, I_D = 0.75A \cdot T_J = 5°C$	Q		0.25 0.29 0.16	0.4 0.5 0.6	
r <sub>DS(on)</sub>	Resistance	$V_{GS} = -4.5V, I_D = -0.$ $V_{GS} = -2.7V, I_{CS} = -2.5$	02	38	0.87 1.20	1.1 1.5	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{GS} = -4 F$ $I_D = -14$ = 125°C $V_{DS} = 5, I_L$ 0.75A $V_{DS}$ -5V, $I_D$ -0.41A	Q1 Q2	5	1.?∠ 3 8	1.9	S
Dynamic	Characteristics		R	2	Mr		
C <sub>iss</sub>	Input Capacitance	Q V <sub>DS</sub> - 10V, ∀ <sub>CS</sub> = 0V, f= 1₩- Z	Q1 Q.	36	90 70	120 100	pF
C <sub>oss</sub>	Output Capa ance	Q2 V <sub>DS</sub> = -10v, V <sub>GS</sub> = 0V f= 1MHZ	Q1 Q2		20 30	30 40	pF
C <sub>rss</sub>	Rei Trai, ir Caplitance	Fo THOFON	Q1 Q2		15 15	25 25	pF
Switchin	Characte stics (note 2)	COLLE					
n)	i 1-On Delay lime		Q1 Q2		4 6	10 12	ns
t <sub>r</sub>	Rise Tin d	$V_{DL} = 5V, I_D = 0.5A,$ $V_{SS} = 4.5V, R_{GEN} = 6\Omega$ Q2	Q1 Q2		1 16	10 29	ns
t <sub>d(off)</sub>	Turn-Off Dela, Time	$V_{DD} = -5V, I_D = -0.5A,$ $V_{GS} = -4.5V, R_{GEN} = 6\Omega$	Q1 Q2		9 35	18 56	ns
5 V	Fall Time		Q1 Q2		1 40	10 64	ns
Qg	Total Gate Charge	Q1	Q1 Q2		1.03 1.20	1.44 1.68	nC
Q <sub>gs</sub>	Gate to Source Charge	V <sub>GS</sub> =4.5V, V <sub>DD</sub> = 5V, I <sub>D</sub> = 0.75A Q2	Q1 Q2		0.29 0.31		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	V <sub>GS</sub> = -4.5V, V <sub>DD</sub> = -5V, I <sub>D</sub> = -0.41A	Q1 Q2		0.17 0.22		nC

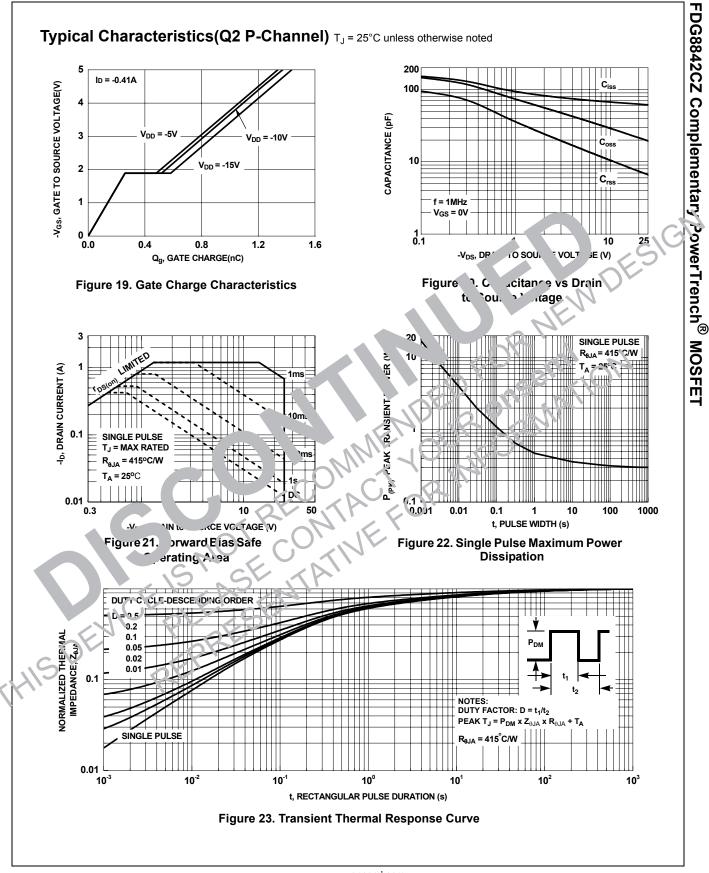
Symbol	Р	arameter	Test Conditio	ns	Туре	Min	Тур	Max	Units
Drain-So	urce Diode Ch	naracteristics an	d Maximum Ratings	i					
I <sub>S</sub>	Maximum Conti	nuous Drain-Source D	Diode Forward Current		Q1 Q2			0.3 0.3	Α
V <sub>SD</sub>	Source to Drain	Diode Forward Voltag	ge $V_{GS} = 0V, I_S = 0.3A$ $V_{GS} = 0V, I_S = -0.3A$	(Note 2) (Note 2)	Q1 Q2		0.76 0.84	1.2 –1.2	V
R <sub>oJC</sub> is gua	Pulse Width < 300µs, D	R <sub>θJA</sub> is determined by the us a. 350°C/W when mounted 1 in <sup>2</sup> pad of 2 oz copper	on a	b. 415	5°C/W when 2 oz copper	n mounte	, a min.		FESK
3	2								
	K								





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